## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/963,292	LOUIE ET AL.	
Examiner	Art Unit	
MICHAEL Y. WON	2455	

SEARCHED						
Class	Subclass	Date	Examiner			
709	201, 223, 245, 246	3/23/2009	MW			
705	1	3/23/2009	MW			
707	ALL	3/23/2009	MW			
714	ALL	3/23/2009	MW			

Class	Subclass	Date	Examine
709	224	3/23/2009	MW
			100

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	3/23/2009	MW			
NPL SEARCH: IEEE	3/23/2009	MW			